

AN1141 PI3USB30532 and PI3USB31532 Application Note for Type-C Applications

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1.0 Introduction

The PI3USB30532 and PI3USB31532 Type-C cross switch family is developed using cutting-edge technology to achieve high performance of DP 1.2, DP 1.3, USB 3.0, USB 3.1 signals in type-C applications. PI3USB3X532 is fully compliant to Type-C specifications. PI3USB3X532 was first to the market and successfully designed in many varying applications, such as notebooks, tablets, AIO, PCs, monitors, HDTVs, docking stations, etc. The PI3USB3X532 was also designed in Intel[®] reference schematic and designed in Intel customer reference demonstration tablet.

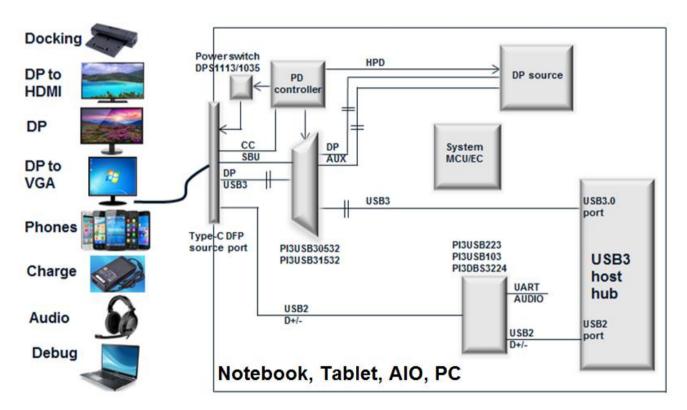
2.0 Why passive MUX (PI3USB3X532) is better than active MUX in notebook design?

The market needs for notebooks are:

- 6-8 hours in battery running time
- ability to boot-up 6-8 days after power-off

Intel mobile CPU/chipset can now achieve 6W power consumption, thus:

- The ~0.4W to ~0.6W power consumption from an active MUX is too high and not acceptable
- Especially when compared to the <0.003W power consumption from PI3USB3X532, which is a 99% power saving compared to an active MUX



3.0 PI3USB3X532 in Source-Host: Notebook, Tablet, AIO and Desktop PC

Figure 1. PI3USB30532, PI3USB31532 in Notebook, Tablet, All-in-One and Desktop PC

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4.0 What are the recommended maximum traces for PI3USB3X532 in Intel notebook design? 4.1 DP 1.2, DP 1.3

In Intel Kaby Lake design guideline, Intel recommends a maximum 8" DP 1.2 trace without passive MUX and 4.1" with passive MUX as to pass a DP 1.2 compliance test.

Intel deducted 3.9" trace from the 8" DP 1.2 trace for the passive MUX, which is conservative for a high performance passive MUX such as PI3USB3X532, as explained in figure 2, figure 3a, figure 3b and in table 1 below.

Based on the PI3USB30532 DP 1.2 eye compliance test results in figure 3a and figure 3b, as well the trace data in figure 2 and table 1, it's recommended as below.

Maximum 6.2" trace for DP 1.2 (5.4Gbps) path, as:

• Intel DP 1.2 source → PI3USB3X532 → Type-C connector

Maximum 4.0" trace for DP 1.3 (8Gbps) path, as:

• Intel DP 1.3 source → PI3USB31532 → Type-C connector

(Assuming the layout and schematics are as recommended as using 90Ω traces without chokes, etc., and in reasonable system conditions)

4.2 USB3.0, USB3.1

Based on the PI3USB30532 USB 3.0 eye compliance test results in figure 4a and figure 4b, as well the trace data in figure 2 and table 1, we recommend the following guidelines:

Maximum 8.5" trace for USB3.0 (5Gbps) path, as:

USB3.0 host → PI3USB3X532 → Type-C connector

Maximum 4.5" trace for USB3.1 (10Gbps) path, as:

• USB3.1 host → PI3USB31532 → Type-C connector

(Assuming the layout and schematics are as recommended below and in reasonable system conditions)

Table 1 - The insertion loss of PI3USB3X532 versus Intel trace board

	Insertion Per inch		PI3USB30532			PI3USB31532		
	loss of 3" trace on Intel trace board		30532: Insertion loss	30532: equivalent trace length (loss of 30532/1" trace)	30532: good-max DP 1.2 trace in Intel 8" trace topology	31532: Insertion loss	31532: equivalent trace length (loss of 31532/1" trace)	31532: good- max DP 1.2 trace in Intel 8" trace topology
Insertion loss at 5Gbps (USB3.0)	-2.1db	-0.70db	-1.2db	1.71" (1.2db/0.70 db)	N/A	-1.06db	1.51" (1.06db/0.7 0db)	N/A
Insertion loss at 5.4Gbps (DP1.2)	-2.3db	-0.77db	-1.3db	1.69" (1.3db/0.77 db)	6.31" (8"-1.69")	-1.23db	1.60" (1.23db/0.7 7db)	6.40" (8"- 1.60")
Insertion loss at 8Gbps (DP1.3)	-3.2db	-1.07db	N/A	N/A	N/A	-1.63db	1.52" (1.63db/1.0 7db)	N/A
Insertion loss at 10Gbps (USB3.1)	-3.96db	-1.32db	N/A	N/A	N/A	-1.68db	1.27" (1.68db/1.3 2db)	N/A

Table 1 the insertion loss of the 3" FR4 differential trace was measured using Intel trace board and Agilent N5230A 20GHz Network Analyzer, as setup in Figure 2.

Note:

 The data above is not linear, because the performances vary with different switch-routings and signaltypes between PI3USB30532 and PI3USB31532, while PI3USB31532 has better performance than PI3USB30532 mostly at higher speed

• N/A is for not applicable



4.3 The insertion loss of 3" differential trace on Intel trace board

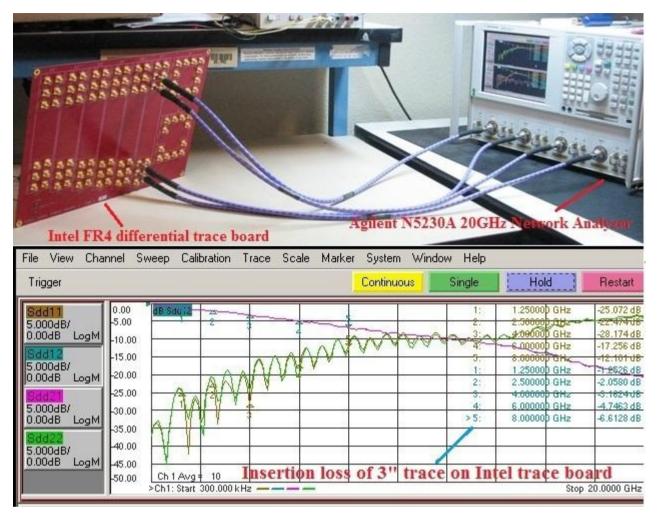
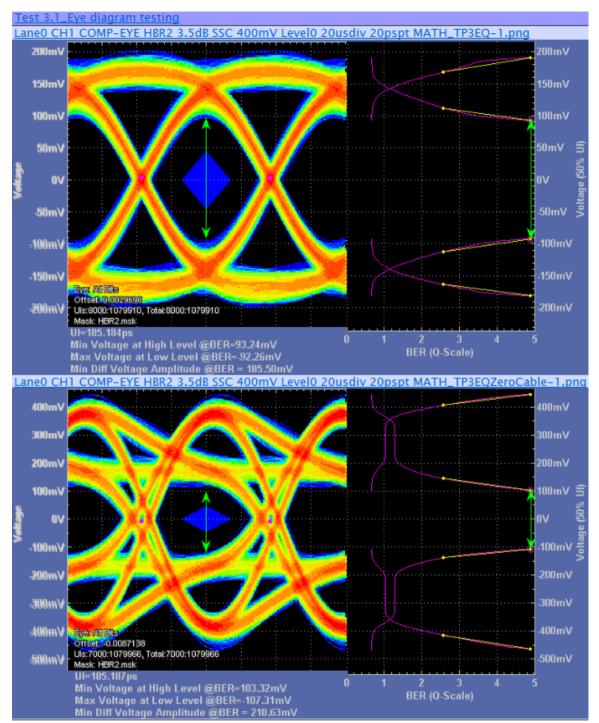


Figure 2. The insertion loss of 3" FR4 differential trace on Intel trace board is measured using Agilent N5230A 20GHz Network Analyzer (chart by James Liu)





4.4 The PI3USB30532 Intel Haswell MB DP 1.2 eye compliance test result

Figure 3a. The eye of DP 1.2 (5.4Gbps) compliance test using PI3USB30532 setup (figure 3b) with Asus[®] H97i-plus MB (Intel Haswell) and 7" trace passed the DP 1.2 HBR2 compliance test 3.1 using Tektronix scope at 400mV, 3.5db pre-emphasis. The upper waveform is at T3 with emulation cable in scope. The lower waveform is at T2 without emulation cable (waveform by Jerry Chou).



4.5 Test Setup

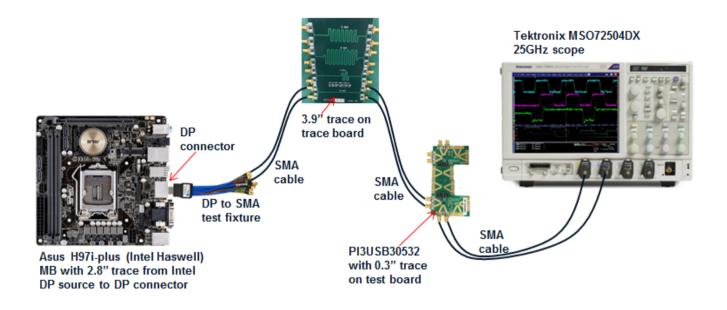


Figure 3b. The test setup of PI3USB30532 with 7" trace (2.8"+3.9"+0.3") using Intel Haswell DP 1.2 source passed DP 1.2 (5.4Gbps) eye compliance test 3.1 as in figure 3a



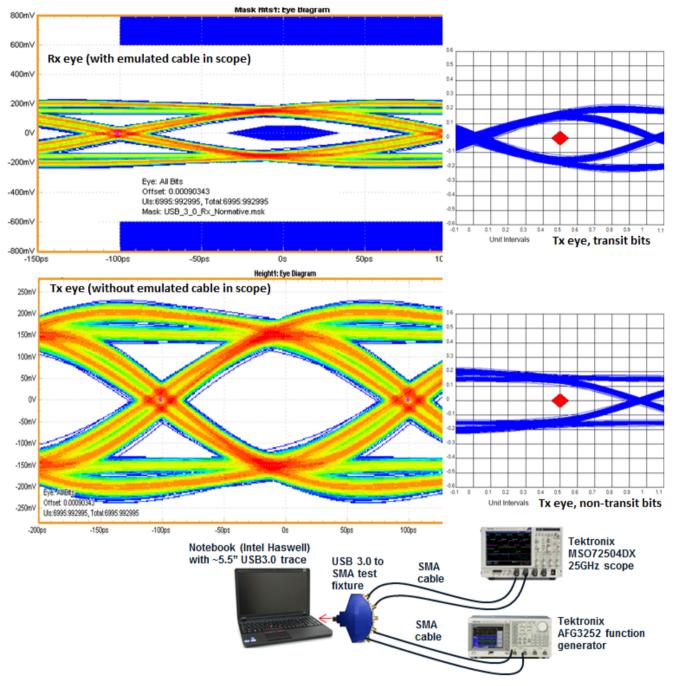


Figure 4a. The Tx and Rx eyes passed the USB 3.0 (5Gbps) compliance test at the USB 3.0 connector of notebook (Intel Haswell) without PI3USB30532 EV board. To be compared to figure 4b with PI3USB30532 EVB (waveform by Jerry Chou)



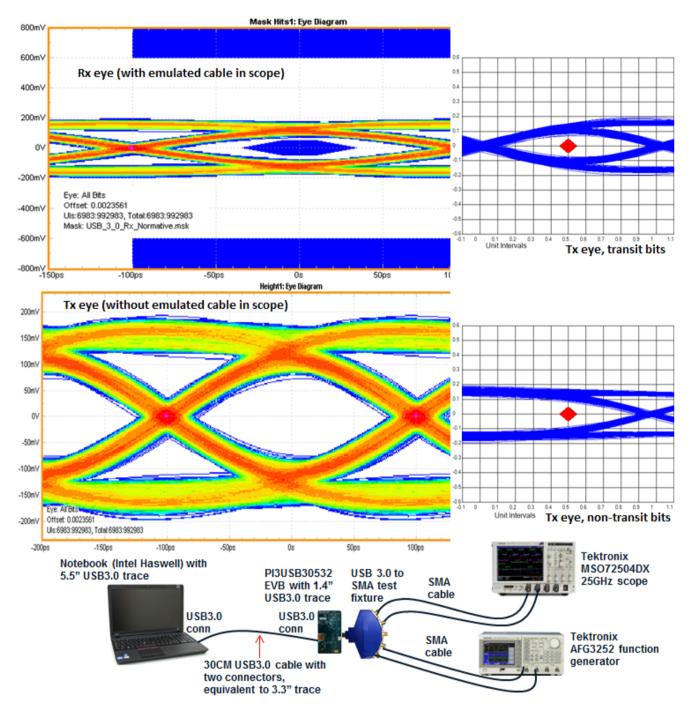


Figure 4b. The Tx and Rx eyes passed USB 3.0 (5Gbps) compliance test with 10.2" trace (5.5"+3.3"+1.4") using notebook (Intel Haswell) and PI3USB30532 EV board. To be compared to figure 4a without PI3USB30532 EV board (waveform by Jerry Chou).



5.0 PI3USB3X532 in Sink-device: Monitor and HDTV

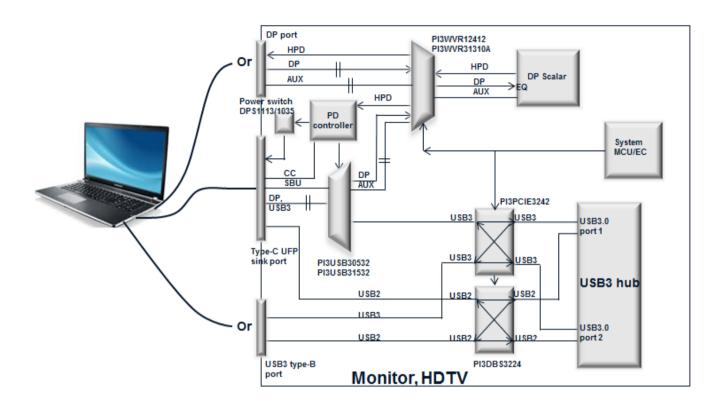
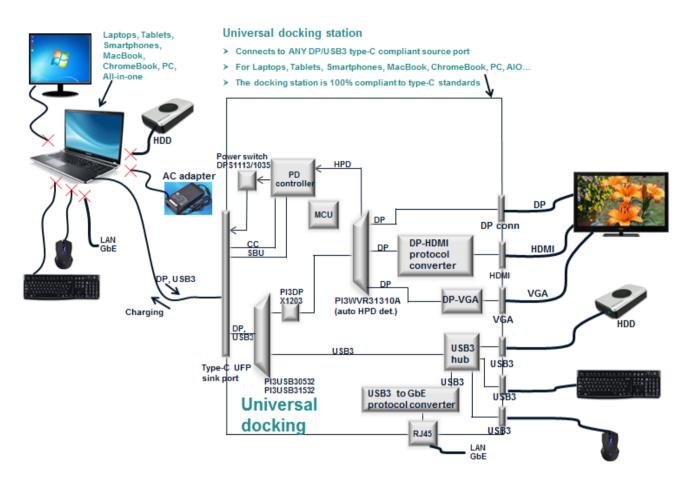


Figure 5. PI3USB30532, PI3USB31532 in monitor and HDTV

- No active DP re-driver and USB3.0 re-driver needed in type-C MUX (PI3USB30532) or • between the switches in cascading (PI3USB30532, PI3WVR12412, PI3PCIE3242). 0
 - Because there are sufficient total source and sink equalization, as:
 - Up to 9db output pre-emphasis (equalization) in DP source and USB3.0 Tx
 - Up to 9db input equalization in DP scalar and USB3.0 Rx receiver.
 - The total 18db equalization in source and sink is sufficient to compensate the 0 estimated total insertion loss from the topology in figure 5:
 - Max 7.7db from total 10" traces
 - Max 4db from 2m type-Cable
 - Max 1.5db from PI3USEB30532 .
 - Max 1.5db from PI3WVR12412 or PI3PCIE3242



6.0 PI3USB3X532 in Sink-device: Docking Station



7.0 The I2C Control of PI3USB3X532

PI3USB3X532 has total three I2C registers: Conf [2:0], which is mapped between the I2C control signals and the configuration tables (source, sink) as in figure-7.

When using I2C interface to control PI3USB3X532, the I2C controller (in PD or MCU) will need sending total three bytes to PI3USB30532 in sequence as:

Start \rightarrow

 \rightarrow #1 byte for address as "10101000" (assuming A1_A0 set to 00, while last 0 for write)"

 \rightarrow #2 byte for chip-ID as fixed "00000000"

→#3 byte for Conf [2:0] control as "00000111" (assuming Conf [2:0]=111 as for USB3+DPx2 swapped)

→Stop (must have stop, otherwise uncertainty may occur)



Switch	Open	Open	4 lane of DP1.2	4 lane of DP1.2 Swap	USB3	USB3 Swap	USB3 +2 lane of DP1.2		+2 lane of .2 Swap
Conf[2:0] 000		001	010 011		100	101	110 1		111
Configu <mark>r</mark> at	tion Table	for Sin	ık Applio	ation (pag	e 4)				
Switch	Open	Open	4 lane of DP1.2	4 lane of DP1.2 Swap	USB3	USB3 Swap	USB3 +2 lane of DP1.2		+2 lane of .2 Swap
Conf[2:0]	000	001	010	011	100	101	110		111
2C Control re	sister: (page	≥ 8)							
					Reg	ister Bits			
		Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
Slave address (slave address)		1	0	1	0	1	A1	A0	0/1 (W/R)
Vendor ID (See vendor ID, rea		0	0	0	0	0	0	0	0
Selection contr byte is for selec read/write)			0	0	0	0	conf[2]	conf[1]	conf[0]
(page 8	SDA		8 9 8 9	DATA (Vendor ID, read	8 9 ACK	DATA (Selection co read/write	e) S	P	

Configuration Table for Source Application (page 3)

Figure 7. The I2C-control of the configuration table for source-sink (source-sink tables are the same)

I2C-controls PI3USB30532 in real application

For both source and sink applications, when a type-C plug is plugging into the source or sink type-C connectors with PI3USB30532 and PD, the I2C controller (in PD or MCU) shall I2C-control PI3USB30532 as:

DPx4 only, non-swap: Start →10101000 (last 0 for write) →00000000→00000010→stop DPx4 only, swapped: Start →10101000 →00000000→00000011→stop USB3.0 only, non-swap: Start →10101000 →00000000→00000100→stop USB3.0 only, swapped: Start →10101000 →00000000→00000101→stop USB3+DPx2, non-swap: Start →10101000 →00000000→00000110→stop USB3+DPx2, swapped: Start →1010100 →00000000→00000111→stop



8.0 Power and Power De-coupling

Use 0.1µf in size of 0402 for all the V_{DD} (any power pins) pins of the IC device, as close to the V_{DD} pins as possible, within 2-3mm if feasible.

Use dedicated V_{DD} and GND planes for to minimize the jitters coupled between channel trough power sources.

9.0 Layout Guideline

9.1 Recommend 90 Ω differential impedance trace for differential DP and USB 3.0 signals

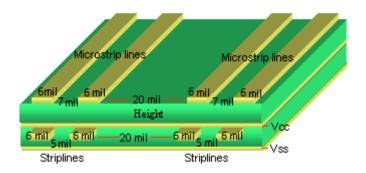


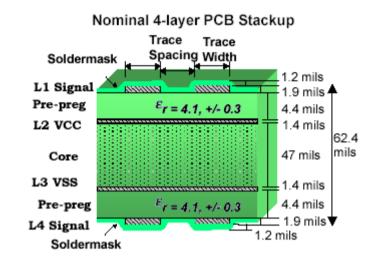
Figure 8. The trace width and clearance

- Use 6-7-6 mils for trace-space-trace for the micro-strip lines (the traces on top and bottom layers) for 90Ω differential impedance.
- Use 6-5-6 mils for trace-space-trace for the strip-lines (the traces inside layers) for 90Ω differential impedance.
- Use FR4.
- Using standard 4 to 8 layers stack-up with 0.062 inch thick PCB.
- □ For micro-strip lines, using ½ OZ Cu plated is ok.
- □ For strip-lines in 6 plus players, using 1 OZ Cu is better.
- □ The trace length miss-matching shall be less than 5 mils for the "+" and "-" traces in the same pairs
- More pair-to-pair spacing for minimal crosstalk
- **□** Target differential Zo of $90\Omega \pm 15\%$



9.2 The PCB Layers Stackup

- No new PCB technology required. Use FR4 is fine.
- Using standard 4 to 8 layers stack-up with 0.062 inch thick PCB.
- For micro strip lines, using ½ OZ Cu plated is ok.
- For strip line in 6 plus players, using 1 OZ Cu is better.





Stackup

Plane	Material	Thickness (mil)		
Solder mask	Mask paint	1.2		
Signal	Copper	1.9		
Prepreg	2116	4.4		
Vcc	Copper	1.4		
Core		47		
Vss	Copper	1.4		
Prepreg	2116	4.4		
Signal	Copper	1.9		
Solder mask	Mask paint	1.2		
Total		62.4		



9.3 The Layout Guidance for the Trace Routings

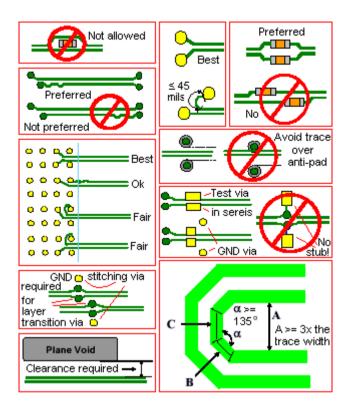
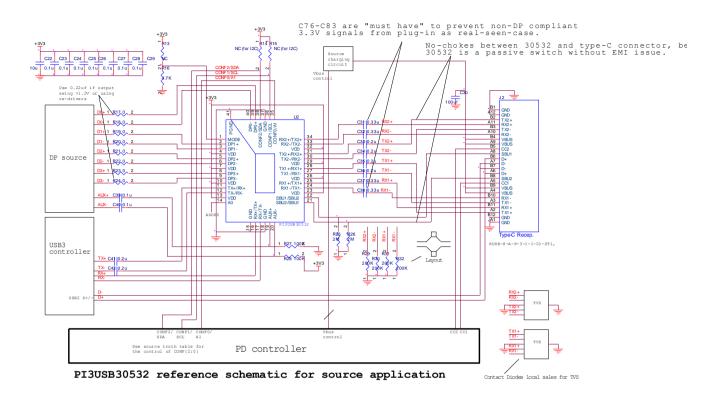


Figure 10. The layout guidance for the trace routings

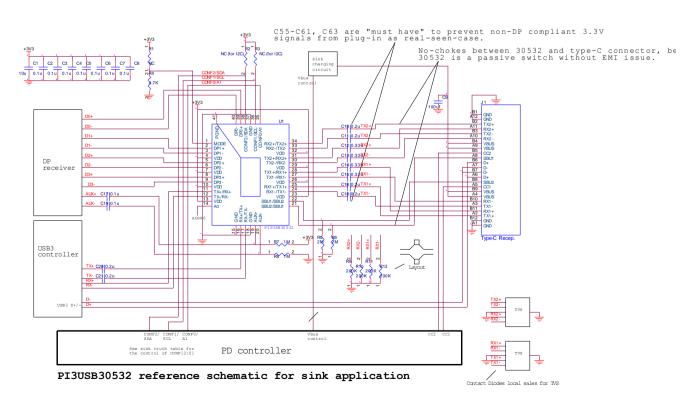
- Don't use EMI chokes, because PI3USB30532 and PI3USB31532 are passive switches not having EMI issues.
- The differential traces shall be away from the strong EMI source and devices, such as TTL, switchingpower traces and devices, with at least 30mil to 50mil space.
- No other components shall piggy ride on the differential traces.



10.0 Appendix: Application Reference Schematics



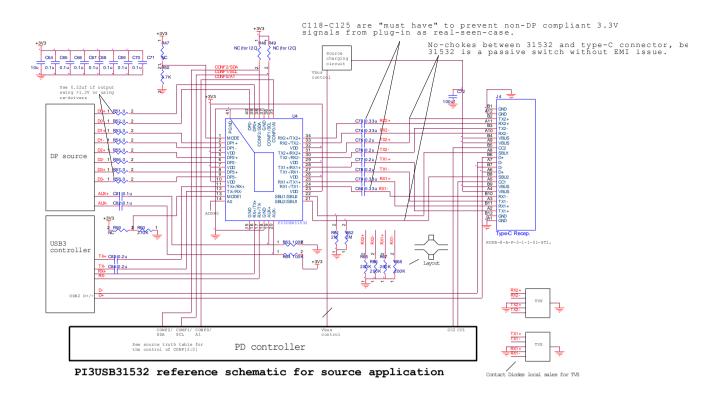
PI3USB30532 DFP-source reference schematic for type-C PD/DP/ALT application



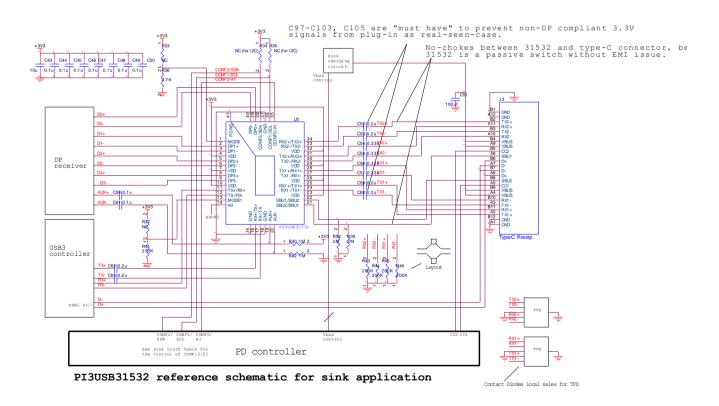
PI3USB30532 UFP-sink reference schematic for type-C PD/DP/ALT application

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